

# Controlling perpendicular electric fields with biased electrodes

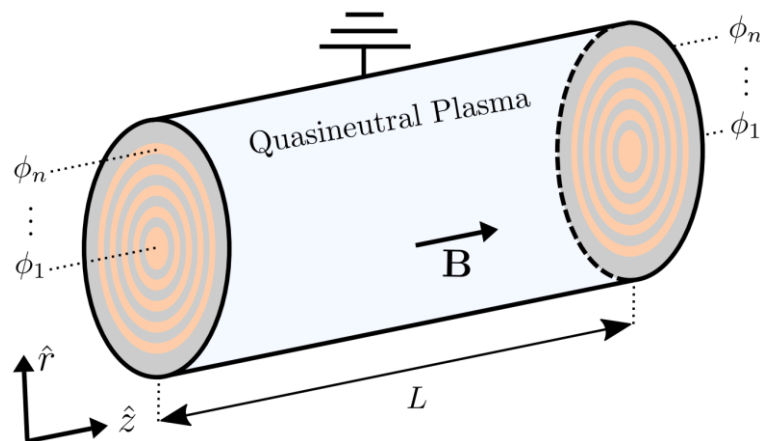
B.Trotabas<sup>1</sup>, R. Gueroult<sup>1</sup>

<sup>1</sup>Laboratoire Plasma et Conversion d'Énergie, Université de Toulouse, CNRS, INPT, UPS, 31062 Toulouse, France

email: [baptiste.trotabas@laplace.univ-tlse.fr](mailto:baptiste.trotabas@laplace.univ-tlse.fr)

The ability to impose and control an electric field perpendicularly to magnetic surfaces in magnetized plasmas is of great importance to a broad range of applications [1]. It has notably been shown in recent years that plasma rotation in  $E \times B$  configurations could offer opportunities to develop new plasma separation techniques [2], as proposed for instance for nuclear spent fuel and rare earth elements recycling [3,4].

A key step to advance these technologies is to understand how the electric potential distributes itself in a magnetized plasma column, and in particular how the perpendicular electric field can possibly be controlled via the electric bias applied on polarized electrodes terminating a magnetized plasma column (see Figure 1). Progress towards this goal requires addressing a pair of basic underlying questions, namely how the electric potential applied on a biased electrode is transferred to the plasma through the sheath [5], and how this potential then varies along a given magnetic field line in a quasi-neutral plasma [6].



**Figure 1 :** Magnetized plasma column terminates on two symmetrical sets of independently biased ring electrodes (in orange) at potential  $(\phi_1, \dots, \phi_n)$  with respect to the grounded vacuum vessel. The entire domain is permeated by a uniform axial magnetic field  $\mathbf{B} = B_0 \hat{z}$ .

So far, these two problems have mostly been treated separately. In this work we consider the particular case of negatively biased electrodes and examine in a unified model the combined effects of biasing and emission on the voltage drop across the sheath and along magnetic field lines.

## References

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